

<b>Notice of References Cited</b>		Application/Control No. 10/783,783	Applicant(s)/Patent Under Reexamination KLENK ET AL.	
		Examiner DIANE YABUT	Art Unit 3734	Page 1 of 1

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*	B	US-6,485,504	11-2002	Johnson et al.	606/216
*	C	US-5,662,683	09-1997	Kay, David B.	606/232
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	M	US-			

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#### NON-PATENT DOCUMENTS

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